E08-010 (N $\rightarrow \Delta$) Analysis Update

Adam Blomberg



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Spokespersons and analysis group

- Temple University
 - ▶ N. Sparveris¹, M. Paolone, A. Blomberg²
- St. Mary's University
 - A.J. Sarty, D. Anez²
- Thomas Jefferson National Accelerator Facility
 - D. Higinbotham
- Massachusetts Institute of Technology
 - S. Gilad
- ¹ Contact person
- Graduate Student



Outline

- Motivation
- Methodology
- Experimental Overview
- Completed Work
- Preliminary Results
- Future Work



Motivation

- Δ Resonance \rightarrow H(e,e'p) π^0
- Nucleon Dynamics
- Quadrupole transition \rightarrow non-spherical components
- Quark-gluon and Mesonic DOF
- Low $Q^2 \rightarrow Pion$ cloud dominates



Sato Lee

40 $10^{-3}/m_{\pi}$

20

0

Pion Cloud

 $Im[M_{1+}^{3/2}]$

2

 $Q^2 (GeV/c)^2$

3

Methodology

 $egin{array}{l} {\sf N}
ightarrow \Delta \ {\sf H}({\sf e},{\sf e}'{\sf p})\pi^0 \end{array}$



$$\sigma = J_{\Omega} \Gamma_{\nu} \frac{\rho_{cm}}{k_{cm}} (R_T + \epsilon_L R_L + \epsilon R_{TT} \cos 2\phi_{X_{\gamma}} + \nu_{LT} R_{LT} \cos \phi_{X_{\gamma}})$$

measure multiple azimuthal angles ϕ for fixed θ to extract $R_T, R_L, R_{TT}, R_{LT} = f(amplitudes(W,Q^2),g(\theta))$

Fit R_i vs. θ to get amplitudes(W,Q²)

Methodology



$$\sigma = J_{\Omega} \Gamma_{\nu} \frac{\rho_{cm}}{k_{cm}} (R_T + \epsilon_L R_L + \epsilon R_{TT} \cos 2\phi_{X_{\gamma}} + \nu_{LT} R_{LT} \cos \phi_{X_{\gamma}})$$

Two in-plane measurements at $\phi = 0^{\circ}$ and $\phi = 180^{\circ}$ allows extraction of resonant amplitudes

 $\sigma_{LT} = f(R_{LT}, \theta_{CM})$

 $\sigma_0 + \epsilon \sigma_{TT} = g(R_T, R_L, R_{TT}, \theta_{CM})$



Signal and BG Sensitivities

 $\begin{array}{l} R_{TT} = 3 \sin^2 \theta \quad (\quad \text{E2} \cdot \text{M1} + (\text{M1})^2 + \dots \sum (\text{background}) \quad) \\ R_{LT} = -6 \cos \theta \sin \theta \quad (\quad \text{C2} \cdot \text{M1} + \dots \sum (\text{background}) \quad) \\ R_T + R_L = (\text{M1})^2 + \dots \sum (\text{background}) \end{array}$

 $R_{TT} \rightarrow \text{sensitivity to EMR}$ $R_{LT} \rightarrow \text{sensitivity to CMR}$ $R_T + R_L \rightarrow \text{sensitivity to M1}$

$$CMR = \frac{C2}{M1}$$



Tails of higher resonances



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 $N \rightarrow \Delta$ Analysis Update

The experiment

- Data taken Feb-Mar 2011
- H(e,e'p)π⁰
 - $N \rightarrow \Delta$
 - π^0 channel
- Two HRSs in coincidence
- 4 and 15 cm LH_2 targets
- Beam energy = 1.16 GeV
- 14 Kinematics
- $Q^2 = 0.04 0.125 \; (GeV/c)^2$
- W = 1.17 1.232 GeV





The Detectors

Vertical Drift Chamber (VDC)

Define Particle Tracks Particle Momentum \vec{p}

Scintillators

DAQ Trigger Coincident Timing

Particle Identification

Cherenkov Lead Glass Showers Scintillators



Completed Work

Calibrations

BCM BPM and Raster VDCs Mispointing cTOF PID

Efficiencies

Live time Multi-hit Events

Target Corrections

Thermal Contraction Window Thickness Beam Offset + End Cap Curvature Target Boiling





BCM





• BPM,Raster





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VDCs After



LHRS: 48° RHRS: 22°

Z vertex from each arm







PMT # vs. L.prl1.a_c[#]

• Pion Rejection Layers



Efficiencies

Live time

 $LT\approx90\%$

Multi-hit Events

Single Track cut \approx 70-80% Correlate VDC Tracks to s2 hits Multi-track analysis \approx 90-95% 15% boost to statistics



Target Length



Target Boiling Test



Coincidence Time of Flight



Missing Mass



Missing Mass











Future Work

- Finalize σ for all kinematics
- Study systematic uncertainties
- Extract resonant amplitudes
- Publication in Fall



Back up Slides

Extra Slides Beyond this point



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Multi Track Events

Percentage of events with specified tracks						
Number of		L arm				
tracks in		1	2	3	>3	
R arm						
	1	72.24	7.68	1.99	0.22	
	2	10.54	1.11	0.28	0.03	
	3	4.38	0.44	0.09	0.01	
	>3	0.87	0.09	0.02	0.00	

Totals:72.24%25.69%2.07%correlateVDC tracks with S2 TDC hitsBreaks when multipleVDC tracks hit the same S2 paddle25.69% \longrightarrow 18.25%+Final MultiTrack scaling:90.49%

Calculating Cross Sections

Average cross section per bin:

$$\frac{d\bar{\sigma}}{d\Omega} = \frac{(N_{det} - N_{bg}) \cdot \epsilon}{N_{PS}} \left(\frac{Y_N}{Y_R}\right)_{model}$$

Scale to central point using model:

$$\frac{d\sigma}{d\Omega} = \frac{d\bar{\sigma}}{d\Omega} \cdot \left(\frac{\sigma_{\text{pt}}}{\sigma_{\text{avg}}}\right)_{\text{model}}$$

 ϵ includes efficiency scaling factors such as MT, LT, and cut efficiencies N_{PS} is calculated using MCEEP, normalized for luminosity

